Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/723,278	ITO, MUNEHIRO
Examiner	Art Unit
John P. Trimmings	2138

	SEAR	CHED	
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
-			
	<u> </u>		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
NPL Search: test memory address data clock generator.	2/21/2006	JPT
Dble Patent Search: Negative.	2/21/2006	JPT
Class Search: 714/718,719,42,25,720,30,799,819, 365/200,201. Text strategy attached.	2/21/2006	JPT